

Issue Classification		Application/Control No. 100500831		Applicant(s)/Patent under Reexamination AOKI ET AL.																			
		Examiner Nguyen, Jennifer T		Art Unit: 2629																			
<table border="1"> <thead> <tr> <th colspan="2">ORIGINAL</th> <th colspan="4">INTERNATIONAL CLASSIFICATION</th> </tr> <tr> <th>CLASS</th> <th>SUBCLASS</th> <th colspan="3">CLAIMED</th> <th>NON-CLAIMED</th> </tr> </thead> <tbody> <tr> <td>345</td> <td>87</td> <td>G</td> <td>0</td> <td>9</td> <td>G 3 / 36</td> </tr> </tbody> </table>						ORIGINAL		INTERNATIONAL CLASSIFICATION				CLASS	SUBCLASS	CLAIMED			NON-CLAIMED	345	87	G	0	9	G 3 / 36
ORIGINAL		INTERNATIONAL CLASSIFICATION																					
CLASS	SUBCLASS	CLAIMED			NON-CLAIMED																		
345	87	G	0	9	G 3 / 36																		
CROSS REFERENCE(S) <table border="1"> <thead> <tr> <th colspan="2">SUBCLASS (ONE SUBCLASS PER BLOCK)</th> </tr> </thead> <tbody> <tr> <td>345</td> <td>89 98 100 204 211</td> </tr> <tr> <td></td> <td>212 690</td> </tr> </tbody> </table>						SUBCLASS (ONE SUBCLASS PER BLOCK)		345	89 98 100 204 211		212 690												
SUBCLASS (ONE SUBCLASS PER BLOCK)																							
345	89 98 100 204 211																						
	212 690																						
 																							
Jennifer T. Nguyen (Assistant Examiner) <i>Nicole P. Tran</i> (Legal Instruments Examiner)		07/07/66 (Date)	RICHARD HJERPE SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2600 (Primary Examiner)	7/17/02 (Date)	Total Claims Allowed: 12 O.G. Print Claim(s) 1 O.G. Print Figure 1																		